

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10578857	SAKROWSKI, KLAUS DIETER
	Examiner	Art Unit
	JAEYUN LEE	1791

SEARCHED

Class	Subclass	Date	Examiner
114	357, 361, and 67R	1/11/2010	/JL/
156	94, 71	8/16/2010	/JL/

SEARCH NOTES

Search Notes	Date	Examiner
East Search (US-PGPUB, USPAT, USOCR, FPRS, EPO, JPO, Derwent, and IBM_TDB) and text search	1/25/2010	/JL/
Inventor Search (EDAN)	1/11/2010	/JL/
Consulted Primary Examiner Jeff Aftergut	1/19/2010	/JL/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
See Interference Search (USPAT, UPAD, USPGPUB)		8/16/2010	/JL/

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